Dual Transistor -Power Management

NPN/PNP Dual (Complementary)

Features

- Low $V_{CE(SAT)}$, < 0.5 V
- These are Pb-Free Devices

MAXIMUM RATINGS

Q1

Rating	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	50	Vdc
Collector-Emitter Voltage	V _{CEO}	50	Vdc
Collector Current	Ι _C	100	mAdc

Q2

Rating	Symbol	Value	Unit
Collector – Emitter Voltage	V _{CEO}	-60	V
Collector – Base Voltage	V _{CBO}	-50	V
Emitter – Base Voltage	V _{EBO}	-6.0	V
Collector Current – Continuous	۱ _C	-100	mAdc

THERMAL CHARACTERISTICS

	-			
Characteristic (One Junction Heated)	Symbol	Мах	Unit	
Total Device Dissipation $T_A = 25^{\circ}C$	PD	357	mW	
Derate above 25°C		(Note 1) 2.9 (Note 1)	mW/°C	
Thermal Resistance, Junction-to-Ambient	R_{\thetaJA}	350 (Note 1)	°C/W	
Characteristic				
(Both Junctions Heated)	Symbol	Max	Unit	
Total Device Dissipation $T_A = 25^{\circ}C$	PD	500	mW	
Derate above 25°C		(Note1) 4.0 (Note 1)	mW/°C	
Thermal Resistance, Junction-to-Ambient	R_{\thetaJA}	250 (Note 1)	°C/W	
Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C	

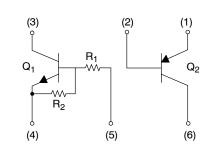
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. FR-4 @ Minimum Pad.



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SOT-563 CASE 463A PLASTIC

MARKING DIAGRAM



UV = Specific Device Code M = Date Code = Pb-Free Package .

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
EMF18XV6T5	SOT–563 (Pb–Free)	8000/Tape & Reel
EMF18XV6T5G	SOT–563 (Pb–Free)	8000/Tape & Reel

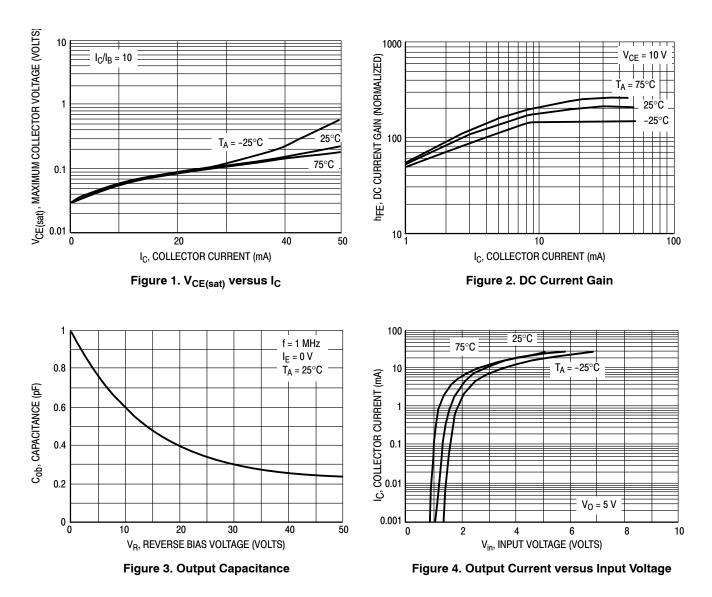
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications

ELECTRICAL CHARACTERISTICS (T_A = 25° C) (Note 2)

Characteristic	Symbol	Min	Тур	Max	Unit
Q1: NPN	•	•			
Collector-Base Cutoff Current (V _{CB} = 50 V, $I_E = 0$)	I _{CBO}	-	-	100	nAdc
Collector-Emitter Cutoff Current ($V_{CE} = 50 \text{ V}, I_B = 0$)	I _{CEO}	-	-	500	nAdc
Emitter-Base Cutoff Current (V_{EB} = 6.0 V, I_C = 0)	I _{EBO}	-	-	0.1	mAdc
Collector-Base Breakdown Voltage ($I_C = 10 \ \mu A$, $I_E = 0$)	V _{(BR)CBO}	50	-	-	Vdc
Collector-Emitter Breakdown Voltage (Note 4) (I_C = 2.0 mA, I_B = 0)	V _{(BR)CEO}	50	-	-	Vdc
DC Current Gain (V_{CE} = 10 V, I_C = 5.0 mA)	h _{FE}	80	140	-	
Collector-Emitter Saturation Voltage (I _C = 10 mA, I_B = 0.3 mA)	V _{CE(sat)}	-	-	0.25	Vdc
Output Voltage (on) (V_{CC} = 5.0 V, V_B = 3.5 V, R_L = 1.0 k\Omega)	V _{OL}	-	-	0.2	Vdc
Output Voltage (off) (V_{CC} = 5.0 V, V_B = 0.5 V, R_L = 1.0 k\Omega)	V _{OH}	4.9	-	-	Vdc
Input Resistor	R1	32.9	47	61.1	kΩ
Resistor Ratio	R1/R2	0.8	1.0	1.2	
Q2: PNP	•	•			
Collector-Base Breakdown Voltage (I _C = $-50 \ \mu$ Adc, I _E = 0)	V _{(BR)CBO}	-60	-	-	Vdc
Collector-Emitter Breakdown Voltage ($I_{C} = -1.0 \text{ mAdc}, I_{B} = 0$)	V _{(BR)CEO}	-50	-	-	Vdc
Emitter-Base Breakdown Voltage (I _E = $-50 \ \mu$ Adc, I _E = 0)	V _{(BR)EBO}	-6.0	-	-	Vdc
Collector-Base Cutoff Current (V _{CB} = -30 Vdc, I _E = 0)	I _{CBO}	_	-	-0.5	nA
Emitter-Base Cutoff Current ($V_{EB} = -5.0 \text{ Vdc}$, $I_B = 0$)	I _{EBO}	-	-	-0.5	μA
Collector-Emitter Saturation Voltage (Note 4) ($I_C = -50$ mAdc, $I_B = -5.0$ mAdc)	V _{CE(sat)}	-	-	-0.5	Vdc
DC Current Gain (Note 4) (V_{CE} = -6.0 Vdc, I_{C} = -1.0 mAdc)	h _{FE}	120	-	560	-
Transition Frequency (V _{CE} = -12 Vdc, I _C = -2.0 mAdc, f = 30 MHz)	f _T	-	140	-	MHz
Output Capacitance (V _{CB} = -12 Vdc, I _E = 0 Adc, f = 1.0 MHz)	C _{OB}	_	3.5	-	pF

3. Device mounted on a FR-4 glass epoxy printed circuit board using the minimum recommended footprint. 4. Pulse Test: Pulse Width \leq 300 µs, D.C. \leq 2%.

TYPICAL ELECTRICAL CHARACTERISTICS — Q1, NPN



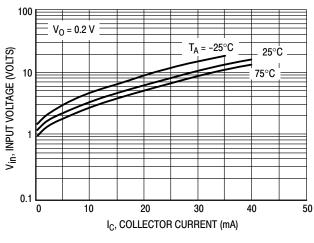
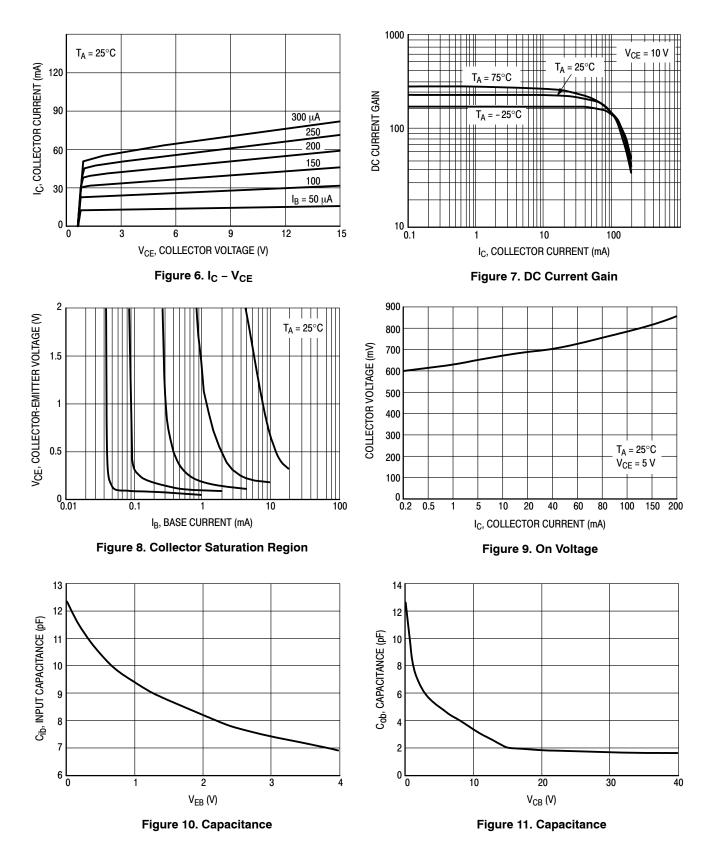


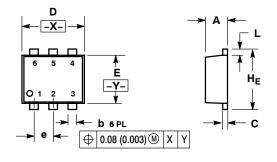
Figure 5. Input Voltage versus Output Current

TYPICAL ELECTRICAL CHARACTERISTICS – Q2, PNP



PACKAGE DIMENSIONS

SOT-563, 6 LEAD CASE 463A-01 ISSUE F

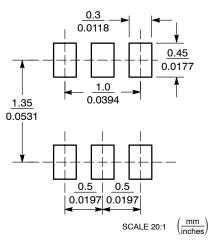


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.021	0.023	
b	0.17	0.22	0.27	0.007	0.009	0.011	
С	0.08	0.12	0.18	0.003	0.005	0.007	
D	1.50	1.60	1.70	0.059	0.062	0.066	
Е	1.10	1.20	1.30	0.043	0.047	0.051	
е	0.5 BSC			0	0.02 BSC		
L	0.10	0.20	0.30	0.004	0.008	0.012	
HE	1.50	1.60	1.70	0.059	0.062	0.066	

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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